Notice of References Cited

Application/Control No. 10/721,660	Reexamination	Applicant(s)/Patent Under Reexamination NATESAN ET AL.		
Examiner	Art Unit			
Shew-Fen Lin	2166	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,707,421	03-2004	Drury et al.	342/357.1
*	В	US-2001/0029429	10-2001	Katayama et al.	701/209
*	С	US-2001/0043745	11-2001	FRIEDERICH et al.	382/232
*	D	US-6,038,559	03-2000	Ashby et al.	707/4
*	E	US-6,073,076	06-2000	Crowley et al.	701/208
*	F	US-6,212,474	04-2001	Fowler et al.	701/211
*	G	US-6,320,518	11-2001	Saeki et al.	340/995.12
*	Н	US-6,324,467	11-2001	Machii et al.	701/200
*	ı	US-6,526,284	02-2003	Sharp et al.	455/456.6
	J	US-			
	К	US-			
	L	US-	X X		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0943894A2	09-1999	European	Livshutz et al.	G01C 21/20
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	υ			
	v			
	w			
	x			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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